## IAP20 Rec'd PCT/PTO 0 3 APR 2006 IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Scheuten et al. Serial No.: To be assigned Filed: Herewith U.S. National Phase of PCT/EP2004/010615 filed September 22, 2004 For: SPHERICAL OR GRAIN-SHAPED SEMICONDUCTOR ELEMENT FOR USE IN SOLAR CELLS AND METHOD FOR PRODUCING THE SAME; METHOD FOR PRODUCING A SOLAR CELL **COMPRISING SAID** SEMICONDUCTOR ELEMENT AND **SOLAR CELL** Group Art Unit: To be assigned

EV686094936US.
Date of Deposit: April 3, 2006

I hereby certify that this paper is being deposited with the United States Postal Service "EXPRESS MAIL POST OFFICE TO ADDRESSEE" service under 37 CFR §1.10 on the date indicated above and is addressed to: Mail Stop PCT, Commissioner for Patents,

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## INFORMATION DISCLOSURE STATEMENT

Mail Stop PCT Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Examiner: To be assigned

Sir:

The documents listed on the enclosed Form PTO-1449 are identified pursuant to 37

CFR §§ 1.56, 1.97, and 1.98. Copies of the documents are enclosed as required.

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Entry and consideration of the submitted documents are solicited.

Respectfully submitted,

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By:

April 3, 2006

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Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Atty. Docket No. 30882/40950	0/5/4633			
INFORMATION DISCLOSURE STATEMENT		Applicant Scheuten et al.				
	EGGCICE STITLEMENT	Filing Date	Group			
	•	September 22, 2004	<b>,</b>			

Document Number	Issue Date	Name	Class	Subclass	Filing Date if Appropriate
3,736,476	05/29/73	Te Velde	317	234 R	
3,998,659	12/21/76	Wakefield	136	89 R	
4,173,494	11/06/79	Johnson et al.	136	89 TF	
4,335,266	06/15/82	Mickelsen et al.	136	260	
4,581,108	04/08/86	Kapur et al.	204	37.1	
5,567,469	10/22/96	Wada et al.	427	74	
5,578,503	11/26/96	Karg et al.	437	5	
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	3,736,476 3,998,659 4,173,494 4,335,266 4,581,108 5,567,469	3,736,476       05/29/73         3,998,659       12/21/76         4,173,494       11/06/79         4,335,266       06/15/82         4,581,108       04/08/86         5,567,469       10/22/96	3,736,476       05/29/73       Te Velde         3,998,659       12/21/76       Wakefield         4,173,494       11/06/79       Johnson et al.         4,335,266       06/15/82       Mickelsen et al.         4,581,108       04/08/86       Kapur et al.         5,567,469       10/22/96       Wada et al.	3,736,476       05/29/73       Te Velde       317         3,998,659       12/21/76       Wakefield       136         4,173,494       11/06/79       Johnson et al.       136         4,335,266       06/15/82       Mickelsen et al.       136         4,581,108       04/08/86       Kapur et al.       204         5,567,469       10/22/96       Wada et al.       427	3,736,476       05/29/73       Te Velde       317       234 R         3,998,659       12/21/76       Wakefield       136       89 R         4,173,494       11/06/79       Johnson et al.       136       89 TF         4,335,266       06/15/82       Mickelsen et al.       136       260         4,581,108       04/08/86       Kapur et al.       204       37.1         5,567,469       10/22/96       Wada et al.       427       74

FOREIGN PATENT DOCUMENTS							
*Examiner Initials	Document Number	Publication Date	Country Class	Class	Subclass	Translation	
						Yes	No
	940 860 A1	09/08/99	EPO				·
	100 52 914 A1	05/16/02	Germany			Abstract only	
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						,	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)
"Thin-Film CIS Alloy PV Materials Fabricated Using Non-Vacuum, Particles-Based
Techniques", Eberspacher et al., Thin Solid Films 387, 2001, pp. 18-22
International Search Report in PCT/EP2004/010615 dated March 31, 2005

Examiner	Date Considered		
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not			
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